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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/766,494	CHEN, SHILIN	
Examiner	Art Unit	
Hugh Jones	2128	

SEARCHED			
Class	Subclass	Date	Examiner
703	1-2, 6-7, 10	11/10/2005	HJ
175	331, 376	11/10/2005	HJ
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST, IEEE, GOOGLE	11/10/2005	НЈ